## Sensitive Gate Silicon Controlled Rectifiers

## **Reverse Blocking Thyristors**

PNPN devices designed for high volume, line-powered consumer applications such as relay and lamp drivers, small motor controls, gate drivers for larger thyristors, and sensing and detection circuits. Supplied in an inexpensive plastic TO-226AA package which is readily adaptable for use in automatic insertion equipment.

#### Features

- Sensitive Gate Allows Triggering by Microcontrollers and Other Logic Circuits
- Blocking Voltage to 600 V
- On-State Current Rating of 0.8 A RMS at 80°C
- High Surge Current Capability 10 A
- Minimum and Maximum Values of IGT, VGT and IH Specified for Ease of Design
- Immunity to dV/dt 20 V/µsec Minimum at 110°C
- Glass-Passivated Surface for Reliability and Uniformity
- Pb-Free Packages are Available\*

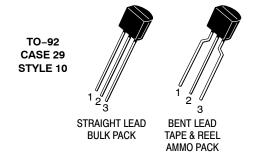


## **ON Semiconductor®**

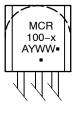
http://onsemi.com

SCRs 0.8 A RMS 100 thru 600 V

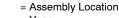




## MARKING DIAGRAM



= Specific Device Code



Y = Year

х

А

WW = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

PIN ASSIGNMENT				
1	Cathode			
2 Gate				
3	Anode			

#### ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage (Notes 1 and 2) ( $T_J$ = -40 to 110°C, Sine Wave, 50 to 60 Hz; $R_{GK}$ = 1 k $\Omega$ ) MCR100–3 MCR100–4 MCR100–6 MCR100–8	V <sub>DRM,</sub> V <sub>RRM</sub>	100 200 400 600	V
On-State RMS Current, (T <sub>C</sub> = 80°C) 180° Conduction Angles	I <sub>T(RMS)</sub>	0.8	А
Peak Non-Repetitive Surge Current, (1/2 Cycle, Sine Wave, 60 Hz, $T_J$ = 25°C)	I <sub>TSM</sub>	10	А
Circuit Fusing Consideration, (t = 8.3 ms)	l <sup>2</sup> t	0.415	A <sup>2</sup> s
Forward Peak Gate Power, (T <sub>A</sub> = 25°C, Pulse Width $\leq$ 1.0 µs)	P <sub>GM</sub>	0.1	W
Forward Average Gate Power, ( $T_A = 25^{\circ}C$ , t = 8.3 ms)	P <sub>G(AV)</sub>	0.01	W
Forward Peak Gate Current, (T <sub>A</sub> = 25°C, Pulse Width $\leq$ 1.0 µs)	I <sub>GM</sub>	1.0	А
Reverse Peak Gate Voltage, (T <sub>A</sub> = 25°C, Pulse Width $\leq$ 1.0 µs)	V <sub>GRM</sub>	5.0	V
Operating Junction Temperature Range @ Rate $V_{\text{RRM}}$ and $V_{\text{DRM}}$	TJ	-40 to 110	°C
Storage Temperature Range	T <sub>stg</sub>	-40 to 150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

V<sub>DRM</sub> and V<sub>RRM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

See ordering information for exact device number options.

#### THERMAL CHARACTERISTICS

Characteristic Thermal Resistance, Junction-to-Case Junction-to-Ambient Lead Solder Temperature (<1/16" from case, 10 secs max)		Symbol	Max		Unit °C/W	
		$R_{ hetaJC}$	75 200	c		
		ΤL	260	°C		
ELECTRICAL CHARACTERISTICS (T <sub>C</sub> = 25°C unless otherwise noted)						
Characteristic	Sym	nbol Mi	n Typ	Max	Unit	
OFF CHARACTERISTICS		-	<u>_</u>	<u>.</u>	_	
$\begin{array}{l} \mbox{Peak Repetitive Forward or Reverse Blocking Current (Note 3)} \\ T_C = 25^\circ C \\ (V_D = Rated \ V_{DRM} \ \mbox{and} \ V_{RRM}; \ R_{GK} = 1 \ \mbox{k}\Omega) \\ T_C = 110^\circ C \end{array}$	I <sub>DRM</sub> ,	I <sub>RRM</sub> –	-	10 100	μΑ	
ON CHARACTERISTICS			•	•		
Peak Forward On–State Voltage <sup>*</sup> ( $I_{TM} = 1.0 \text{ A Peak} @ T_A = 25^{\circ}\text{C}$ )	V <sub>T</sub>	- M	-	1.7	V	
$ \begin{array}{ll} \mbox{Gate Trigger Current (Note 4)} & T_{C} = 25^{\circ} C \\ \mbox{(V}_{AK} = 7.0 \mbox{ Vdc}, \ R_{L} = 100 \ \Omega ) \end{array} $	I <sub>G</sub>	т –	40	200	μΑ	
	۱		0.5	5.0 10	mA	
$ \begin{array}{ll} \mbox{Latch Current (Note 4)} & T_{C} = 25^{\circ} C \\ (V_{AK} = 7.0 \ V, \ \mbox{Ig} = 200 \ \mu \mbox{A}) & T_{C} = -40^{\circ} C \end{array} $	I		0.6 -	10 15	mA	
$ \begin{array}{ll} \mbox{Gate Trigger Voltage (Note 4)} & T_C = 25^\circ C \\ (V_{AK} = 7.0 \mbox{ Vdc}, \ R_L = 100 \ \Omega) & T_C = -40^\circ C \end{array} $	Vc	ат – –	0.62	0.8 1.2	V	
YNAMIC CHARACTERISTICS		-	•	-	-	
Critical Rate of Rise of Off–State Voltage ( $V_D$ = Rated $V_{DRM}$ , Exponential Waveform, $R_{GK}$ = 1 k $\Omega$ , $T_J$ = 110°C)	dV	/dt 20	) 35	-	V/μs	
Critical Rate of Rise of On-State Current (I <sub>PK</sub> = 20 A; Pw = 10 μsec; diG/dt = 1 A/μsec, Igt = 20 mA)	di/	dt –	-	50	A/μs	

\*Indicates Pulse Test: Pulse Width  $\leq$  1.0 ms, Duty Cycle  $\leq$  1%.

3.  $R_{GK}$  = 1000  $\Omega$  included in measurement.

4. Does not include R<sub>GK</sub> in measurement.

## Voltage Current Characteristic of SCR

+ Current

Anode +

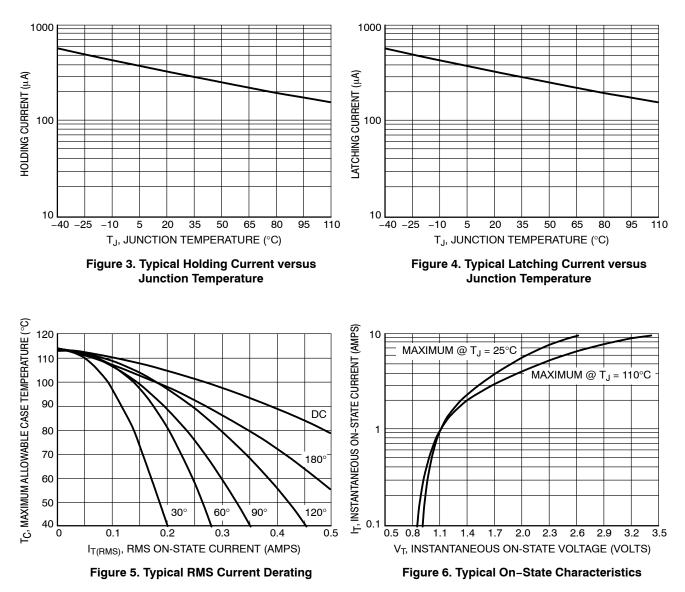
Symbol	Parameter					V™		
V <sub>DRM</sub>	Peak Repetitive Off State Forward Voltage	ge						
IDRM	Peak Forward Blocking Current			on state 2	1.			
V <sub>RRM</sub>	Peak Repetitive Off State Reverse Volta	ge I <sub>RRM</sub>	at V <sub>RRM</sub>		<u>  1</u> <u>  1</u> <u>  1</u>			
I <sub>RRM</sub>	Peak on State Voltage		k on State Voltage		+ Voltag			
V <sub>TM</sub>								
I <sub>H</sub>	Holding Current							
		Á	(off state)	5	Forwa	1	ng Regio	
		\ Reve	erse Avalanche	Region		(off stat		
		Anoc		, rogioni				
00		1-1	1.0					
0								
		TAGE (VOLTS)						
		VOLTAGE (VOLTS)						
00 00 00 00 70 00 00 00		ier voltage (volts)						
		AIGGER VOLTAGE (VOLTS)						
00 00 00 00 00 00 00 00 00		E TRIGGER VOLTAGE (VOLTS)						
		GATE TRIGGER VOLTAGE (VOLTS)						

Figure 1. Typical Gate Trigger Current versus Junction Temperature

T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 2. Typical Gate Trigger Voltage versus Junction Temperature

T<sub>J</sub>, JUNCTION TEMPERATURE (°C)



#### **ORDERING INFORMATION**

Device	Package Code	Shipping <sup>†</sup>		
MCR100-003				
MCR100-004				
MCR100-006		5000 Units / Box		
MCR100-008				
MCR100-3RL	TO 00 (TO 000)			
MCR100-6RL	TO-92 (TO-226)	2000 / Tape & Reel		
MCR100-6RLRA				
MCR100-6RLRM				
MCR100-6ZL1		2000 / Tape & Ammo Pack		
MCR100-8RL		2000 / Tape & Reel		
MCR100-3G				
MCR100-4G		5000 Haita / Dava		
MCR100-6G		5000 Units / Box		
MCR100-8G				
MCR100-3RLG		2000 / Tape & Reel		
MCR100-6RLG	TO-92 (TO-226) (Pb-Free)			
MCR100-6RLRAG	( )			
MCR100-4RLRMG				
MCR100-6RLRMG		2000 / Tape & Ammo Pack		
MCR100-6ZL1G				
MCR100-8RLG		2000 / Tape & Reel		

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## TO-92 EIA RADIAL TAPE IN BOX OR ON REEL

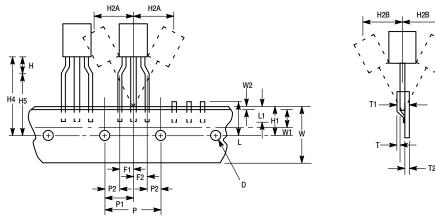


Figure 7. Device Positioning on Tape

			Specif	ication	
		Inc	hes	Millir	neter
Symbol	Item	Min	Max	Min	Max
D	Tape Feedhole Diameter	0.1496	0.1653	3.8	4.2
D2	Component Lead Thickness Dimension	0.015	0.020	0.38	0.51
F1, F2	Component Lead Pitch	0.0945	0.110	2.4	2.8
Н	Bottom of Component to Seating Plane	.059	.156	1.5	4.0
H1	Feedhole Location	0.3346	0.3741	8.5	9.5
H2A	Deflection Left or Right	0	0.039	0	1.0
H2B	Deflection Front or Rear	0	0.051	0	1.0
H4	Feedhole to Bottom of Component	0.7086	0.768	18	19.5
H5	Feedhole to Seating Plane	0.610	0.649	15.5	16.5
L	Defective Unit Clipped Dimension	0.3346	0.433	8.5	11
L1	Lead Wire Enclosure	0.09842	_	2.5	_
Р	Feedhole Pitch	0.4921	0.5079	12.5	12.9
P1	Feedhole Center to Center Lead	0.2342	0.2658	5.95	6.75
P2	First Lead Spacing Dimension	0.1397	0.1556	3.55	3.95
Т	Adhesive Tape Thickness	0.06	0.08	0.15	0.20
T1	Overall Taped Package Thickness	—	0.0567	_	1.44
T2	Carrier Strip Thickness	0.014	0.027	0.35	0.65
W	Carrier Strip Width	0.6889	0.7481	17.5	19
W1	Adhesive Tape Width	0.2165	0.2841	5.5	6.3
W2	Adhesive Tape Position	.0059	0.01968	.15	0.5

NOTES:

1. Maximum alignment deviation between leads not to be greater than 0.2 mm.

2. Defective components shall be clipped from the carrier tape such that the remaining protrusion (L) does not exceed a maximum of 11 mm.

3. Component lead to tape adhesion must meet the pull test requirements.

4. Maximum non-cumulative variation between tape feed holes shall not exceed 1 mm in 20 pitches.

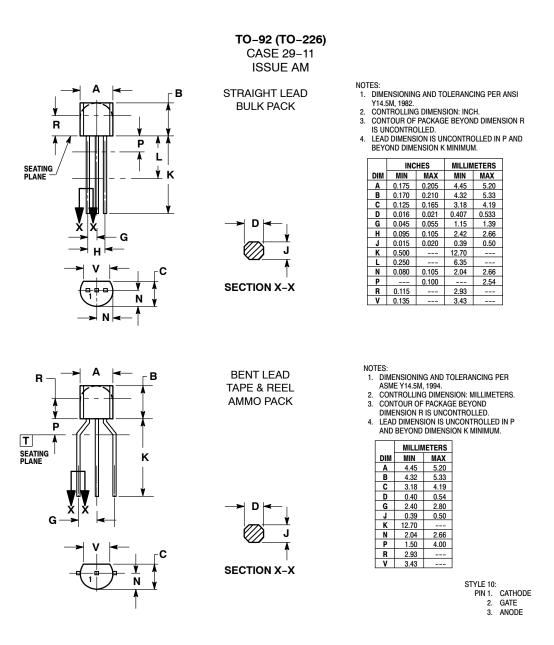
5. Hold down tape not to extend beyond the edge(s) of carrier tape and there shall be no exposure of adhesive.

6. No more than 1 consecutive missing component is permitted.

7. A tape trailer and leader, having at least three feed holes is required before the first and after the last component.

8. Splices will not interfere with the sprocket feed holes.

#### PACKAGE DIMENSIONS



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